

STN4NF03L

N-channel 30 V - 0.039 Ω - 6.5 A - SOT-223 STripFET™ II Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	I _D
STN4NF03L	30 V	<0.05 Ω	6.5 A

■ Low threshold drive

Application

■ Switching applications

Description

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

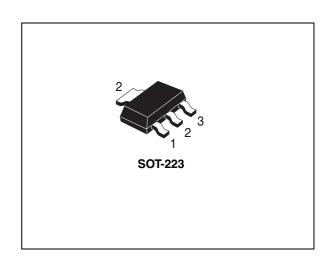


Figure 1. Internal schematic diagram

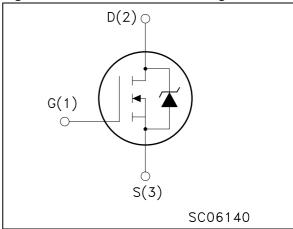


Table 1. Device summary

Order code	Marking	Package	Packaging
STN4NF03L	4NF03L	SOT-223	Tape & reel

Contents STN4NF03L

Contents

1	Electrical ratings	. 3
2	Electrical characteristics	. 4
	2.1 Electrical characteristics (curves)	. 6
3	Test circuit	. 8
4	Package mechanical data	. 9
5	Revision history	11

STN4NF03L Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS}	Gate-source voltage	± 16	V
I _D	Drain current (continuous) at T _C = 25 °C	6.5	Α
I _D	Drain current (continuous) at T _C =100 °C	4.5	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	26	Α
P _{TOT}	Total dissipation at T _C = 25 °C	3.3	W
	Derating factor	0.026	W/°C
E _{AS} (2)	Single pulse avalanche energy	100	mJ
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

^{1.} Pulse width limited by safe operating area

Table 3. Thermal data

Symbol	Parameter	Value	Unit
Rthj-pcb	Thermal resistance junction-PCB ⁽¹⁾ max	38	°C/W
Rthj-pcb	Thermal resistance junction-PCB ⁽²⁾ max 100		°C/W
T _I	Maximum lead temperature for soldering purpose (for 10 sec. 1.6 mm from case) typ	260	°C

^{1.} When mounted on 1 inch 2 FR-4 board, 2 oz. Cu., t < 10 s

^{2.} Starting $T_J = 25$ °C, $I_D = 6$ A

^{2.} Minimum recommended footprint

Electrical characteristics STN4NF03L

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	30			٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating, V_{DS} = max rating @125 °C			1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±16 V			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			٧
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$ $V_{GS} = 5 \text{ V}, I_D = 2 \text{ A}$		0.039 0.046	0.05 0.06	$\Omega \ \Omega$

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 10 V_{,} I_{D} = 1 A$	3	6		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f=1 MHz, } V_{GS} = 0$		330 90 40		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 24 V, I_D = 4 A V_{GS} =10 V (see Figure 14)		6.5 3.2 2	9	nC nC nC

^{1.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time rise time	$V_{DD} = 15 \text{ V}, I_{D} = 2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 4.5 \text{ V}$ (see Figure 15)		11 100		ns ns
t _{d(off)} t _f	Turn-off-delay time fall time	$V_{DD} = 15 \text{ V}, I_{D} = 2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 4.5 \text{ V}$ (see Figure 15)		35 22		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current				6.5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				26	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 6.5 \text{ A}, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 6.5 \text{ A},$ $di/dt = 100 \text{ A/}\mu\text{s},$ $V_{DD} = 15 \text{ V}, \text{ Tj=150 °C}$ (see Figure 15)		34 25 1.4		ns nC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STN4NF03L

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance junction-PCB

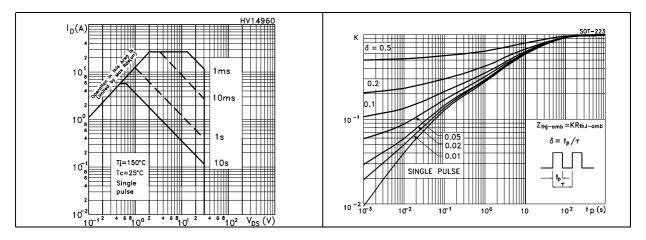


Figure 4. Output characteristics

Figure 5. Transfer characteristics

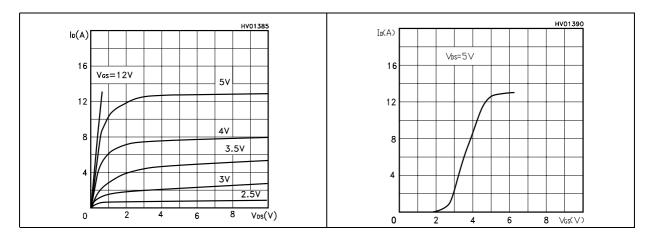
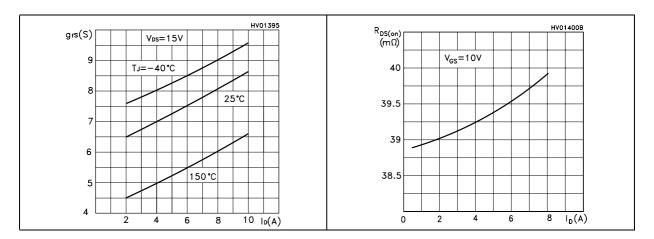


Figure 6. Transconductance

Figure 7. Static drain-source on resistance



6/12

Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

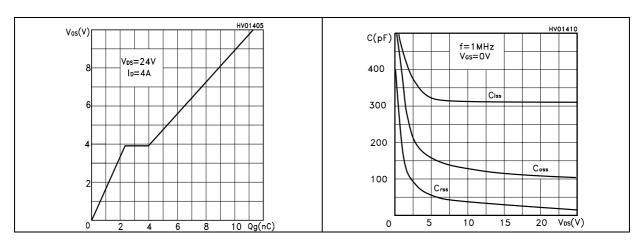


Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs. vs. temperature temperature

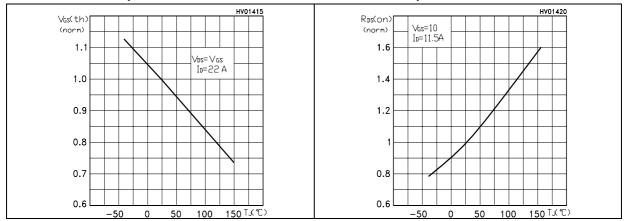
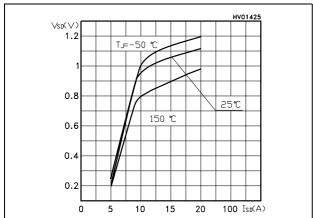


Figure 12. Source-drain diode forward characteristics



577

Test circuit STN4NF03L

3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

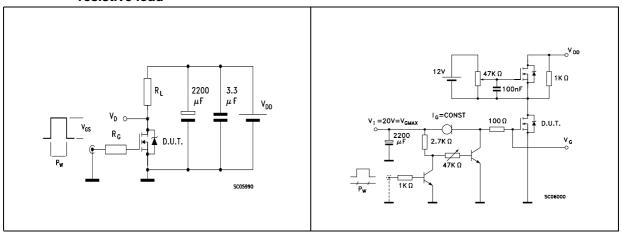


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

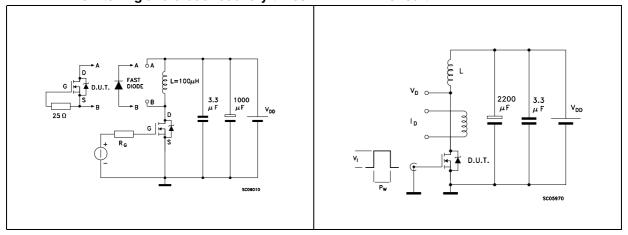
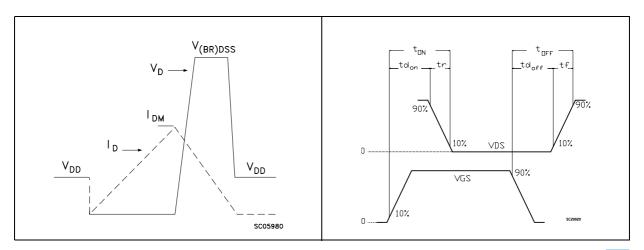


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



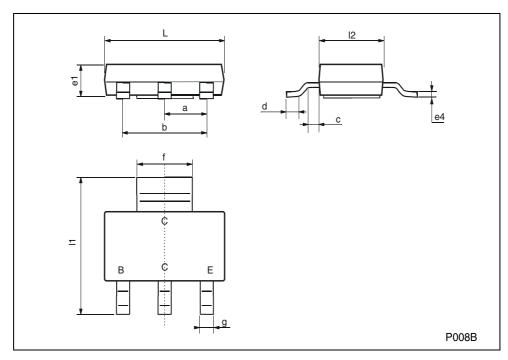
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

9/12

SOT-223 MECHANICAL DATA

DIM.		mm			mils	
2	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a	2.27	2.3	2.33	89.4	90.6	91.7
b	4.57	4.6	4.63	179.9	181.1	182.3
С	0.2	0.4	0.6	7.9	15.7	23.6
d	0.63	0.65	0.67	24.8	25.6	26.4
e1	1.5	1.6	1.7	59.1	63	66.9
e4			0.32			12.6
f	2.9	3	3.1	114.2	118.1	122.1
g	0.67	0.7	0.73	26.4	27.6	28.7
l1	6.7	7	7.3	263.8	275.6	287.4
12	3.5	3.5	3.7	137.8	137.8	145.7
L	6.3	6.5	6.7	248	255.9	263.8



STN4NF03L Revision history

5 Revision history

Table 8. Document revision history

Date	Revision	Changes
21-Jun-2004	3	Initial electronic version. Document status promoted from preliminary data to datasheet
09-Oct-2006	4	Document reformatted no content change
27-Nov-2007	5	Updated marking on Table 1: Device summary
11-Dec-2007	6	Updated E _{AS} value on <i>Table 2: Absolute maximum ratings</i>

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577